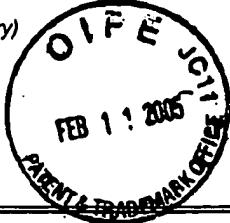


Form PTO-1449  
INFORMATION DISCLOSURE CITATION IN AN  
APPLICATION  
(Use several sheets if necessary)

Docket Number (Optional)  
2270-1-6Application Number  
10/772,143Applicant(s)  
Patrick B. LoveFiling Date  
February 4, 2004Group Art Unit  
2625

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						YES	NO

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER	DATE CONSIDERED
<i>W.C.</i>	12-5-2005

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Form PTO-1449  INFORMATION DISCLOSURE CITATION IN AN APPLICATION <i>(Use several sheets if necessary)</i>		Docket Number (Optional) 2270-1-6		Application Number 10/772,143		
		Applicant(s) Patrick B. Love				
		Filing Date February 4, 2004		Group Art Unit 2625		
<b>U.S. PATENT DOCUMENTS</b>						
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<b>FOREIGN PATENT DOCUMENTS</b>						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation
						YES      NO
<b>OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)</b>						
dk	<input checked="" type="checkbox"/>	MS MacroSystem, Printout from <a href="http://www.msmacrosystem.nl/index.html">http://www.msmacrosystem.nl/index.html</a> , 3D Surface View Software, Pages 1-2, Copyright 1999-2003.				
dk	<input checked="" type="checkbox"/>	MS MacroSystem, Printout from <a href="http://www.msmacrosystem.nl/Forensic/Software.html">http://www.msmacrosystem.nl/Forensic/Software.html</a> , 2D/3D Forensic Software, Pages 1-2, Copyright 1999-2003.				
dk	<input checked="" type="checkbox"/>	MS MacroSystem, Printout from <a href="http://www.msmacrosystem.nl/3Dsurf/About3Dview.html">http://www.msmacrosystem.nl/3Dsurf/About3Dview.html</a> , 3D Surface View: Fast Scientific Visualization, Pages 1-2, Copyright 1999-2003				
dk	<input checked="" type="checkbox"/>	ReindeerGraphics.com, Printout from <a href="http://www.reindeergraphics.com/">http://www.reindeergraphics.com/</a> , Quantitive Image Analysis, Pages 1-3, Copyright 1995-2003.				
dk	<input checked="" type="checkbox"/>	ReindeerGraphics.com, Printout from <a href="http://www.reindeergraphics.com/foveapro2/">http://www.reindeergraphics.com/foveapro2/</a> , Fovea Pro 2.0, Pages 1-3, Copyright 1995-2003.				
dk	<input checked="" type="checkbox"/>	ReindeerGraphics.com, Printout from <a href="http://www.reindeergraphics.com/foveapro2/surface.shtml">http://www.reindeergraphics.com/foveapro2/surface.shtml</a> , Fovea Pro: Surface Analysis, Pages 1-3, Copyright 1995-2003.				
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dk	<input checked="" type="checkbox"/>	Cefncommunication Intelligence Corporation; "Sign-it"; sales literature; Copyright dates 2000, 2001; 3 pages.				
dk	<input checked="" type="checkbox"/>	SG Tech; PenOp; Easy Software, Sales Literature; Copyright 1999,2000; 3 pages.				
dk	<input checked="" type="checkbox"/>	Pikaso Software, Inc.; "Write-On - Handwriting Comparison Software"; sales literature; undated; 2 pages.				
EXAMINER	<i>[Signature]</i>		DATE CONSIDERED 12-05-2005			
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.						

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		Applicant(s) Patrick B. Love				
		Filing Date February 8, 2004		Group Art Unit 2625		
U.S. PATENT DOCUMENTS						
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation
						YES      NO
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)						
<i>dk ✓</i>	Sheila Lowe and Associates; "The Write Choice – Handwriting Analysis Software for Windows"; web site literature printed 10/28/2001 and 10/25/2001; 23 pages.					
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<i>dk ✓</i>	Media Cybernetics; "Image Pro PLUS The Proven Solution"; web site literature; printed 10/18/2001; 8 pages.					
<i>dk ✓</i>	Kitware; "Visualization Toolkit"; web site literature; printed 10/23/2001, 2 pages.					
EXAMINER	<i>dk</i>		DATE CONSIDERED <i>12-05-2005</i>			
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